

Notice of References Cited

Application/Control No.

09/644,068

Applicant(s)/Patent Under
Reexamination
SHIBUYA ET AL.

Examiner

Thomas D. Lee

Art Unit

2624

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,783,837	11-1988	Kawamura et al.	382/270
	B	US-5,553,200	09-1996	Accad, Yigal	358/1.9
	C	US-6,052,203	04-2000	Suzuki et al.	358/1.9
	D	US-6,191,868	02-2001	Shibuya et al.	358/1.9
	E	US-6,326,993	12-2001	Satoh et al.	347/252
	F	US-6,369,911	04-2002	Hattori, Toshiyuki	358/1.9
	G	US-6,476,847	11-2002	Satoh et al.	347/252
	H	US-6,498,617	12-2002	Ishida et al.	347/252
	I	US-6,674,547	01-2004	Kadowaki, Toshihiro	358/3.01
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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